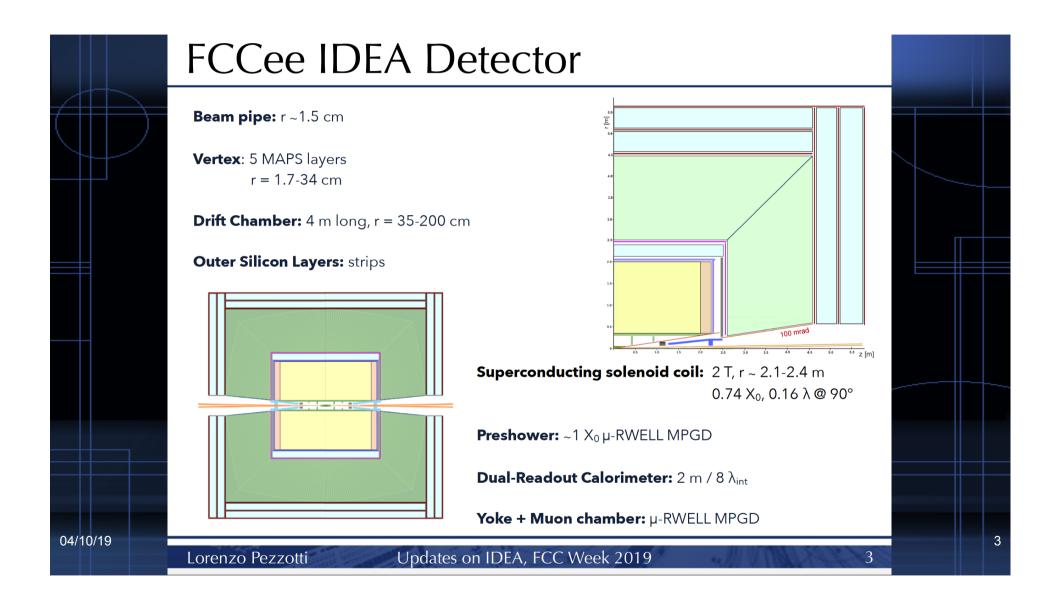


No soft	Disclaimer sparencies are stolen from recent presentations of different authors. tware developments. gnet updates.
	Outline
	 IDEA detector: a few reminders Current activities on Vertex detector Drift Chamber
	Calorimeter Preshower and Muons
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Vertex detector

- Exploring CMOS technologies, since they have the potential for low cost/high throughput
 - VTX: Depleted Monolithic Active Pixels
 - Fast signal
 - Possibility for very thin detectors (low material)
 - Small pitches already realized
 - INFN/CSN5 developments: SEED-ARCADIA
 - One AIDA++ EoI submitted
 - INFN/(CSN5+CSN1) developments: HVR_CCPD-ATLAS
 - One AIDA++ EoI submitted

Outer tracker:

- Proposing passive CMOS sensor (productions by ATLAS/CMS
- on going, part of the ATLAS pixel detector market surveys)
 - One AIDA++ EoI submitted

ARCADIA

(Advanced CMOS Architectures with Depleted Integrated sensor Arrays) INFN CSN5 Call Project targeting a fullsize system-ready demonstrator of a lowpower high density pixel matrix CMOS monolithic sensor featuring:

1. Active sensor thickness in the 50-500 µm range

2. Operating in full depletion fast charge collection by drift

3. Scalable readout architecture with ultralow power capability O(10 mW/cm²)



- Silicon package till now mainly concentrated on application of CMOS technologies
- Assess multi-chip performance of the detectors developed for ATLAS
- Technology of great interest for INFN
- Submitted 5 (3 from IDEA) AIDA++ EoI on CMOS related technologies

SEED—ARCADIA Sensors SEED detector characterization Microbeam scans at RBI – Zagreb Thinning of sensor - Study charge collection of SEED sensors MAIN REQUIREMENTS OF MATISSE TOPSIDE Technology CMOS BSI 0.11 µm 2 MeV protons → good charge collection uniformity Voltage suppl 1.2 V Pseudomatrices of 10 µm – 50 µm pitch, 100 µm – 400 µm sensor thickness Measuren Hit positio Energy Loss Number of channel 24×24 Input dynamic rang up to 24 ke Sancor canaditand $\sim 40 \text{ fF}$ BOTTOM SIDE CSA input common mode v > 600 m Reduce complexity of 2 (~70 fF each) backside treatment Local memorie Noise < 100 e⁻ Shutter type Snapshot shutter orrelated Double Sampling Readout typ Double Sampling Readout speed up to 5 MHz Other feature Internal test pulse Mask mode Baseline regulation Smaller size

from Ittilio

std dev

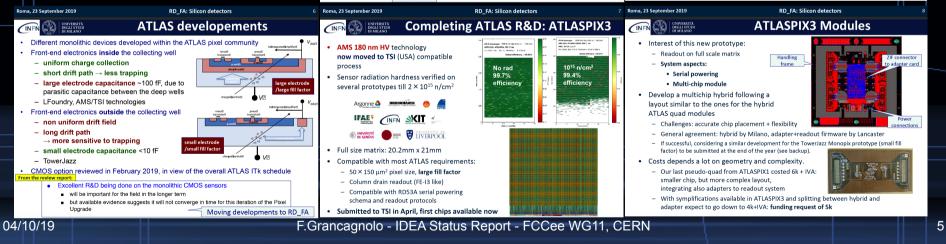
mean

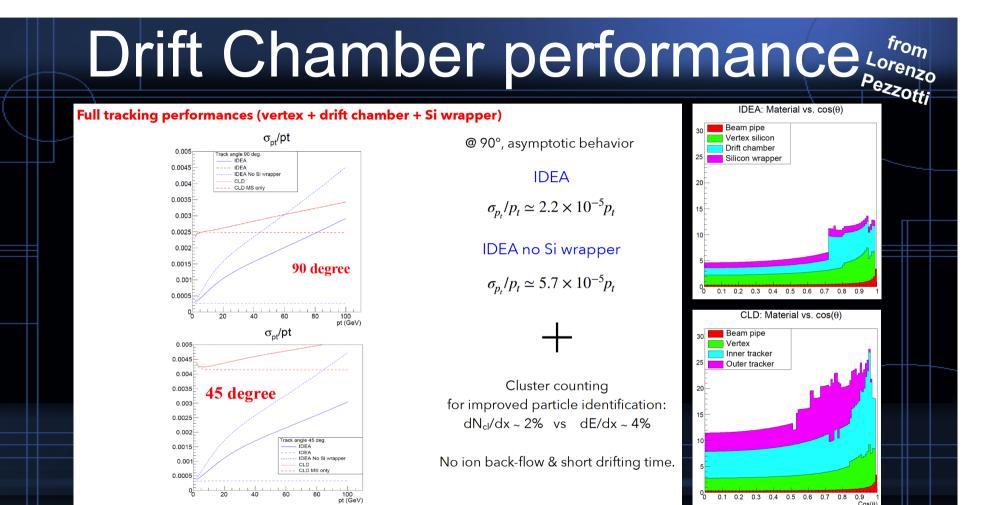
energy

Matrix edge Bias Voltage

Metal lines

RD FA: Silicon detect

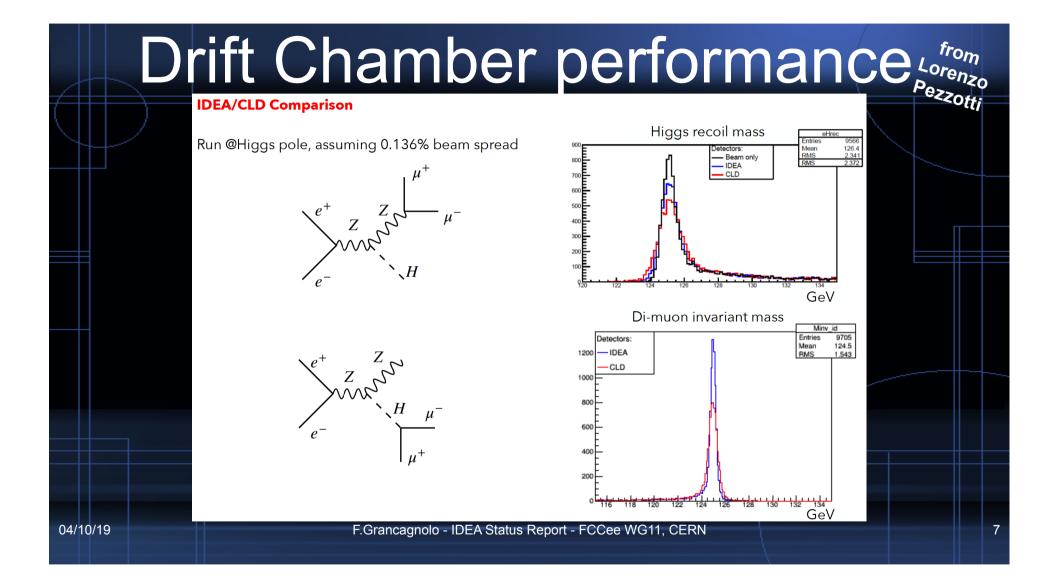


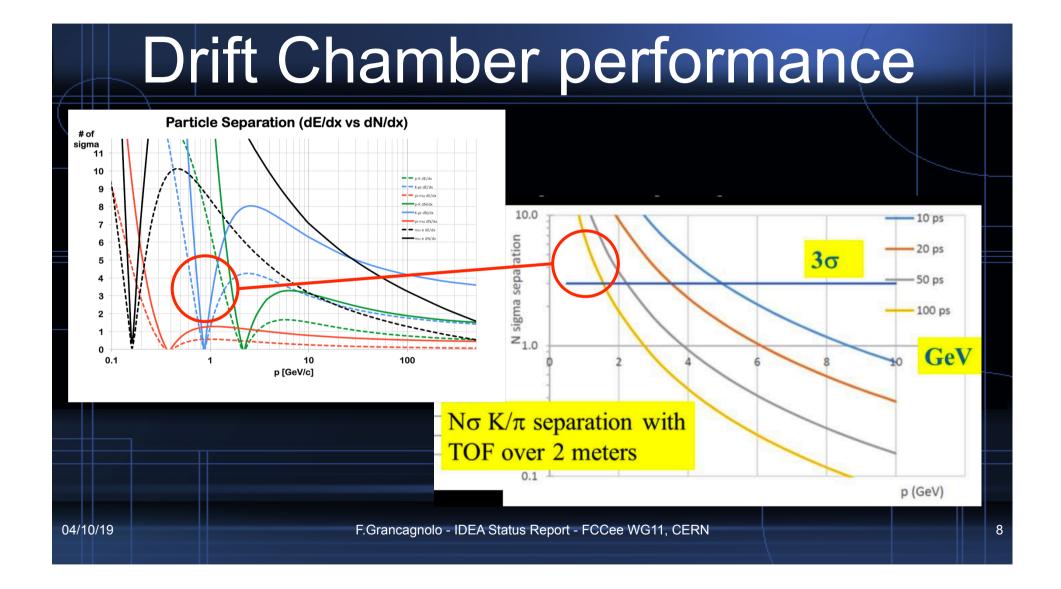


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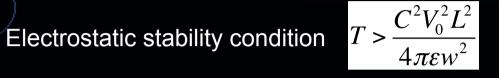




Drift Chamber R&D: wire length

or,

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T = wire tension C = capacitance per unit length V_0 = anode-cathode voltage L = wire length, w = cell width

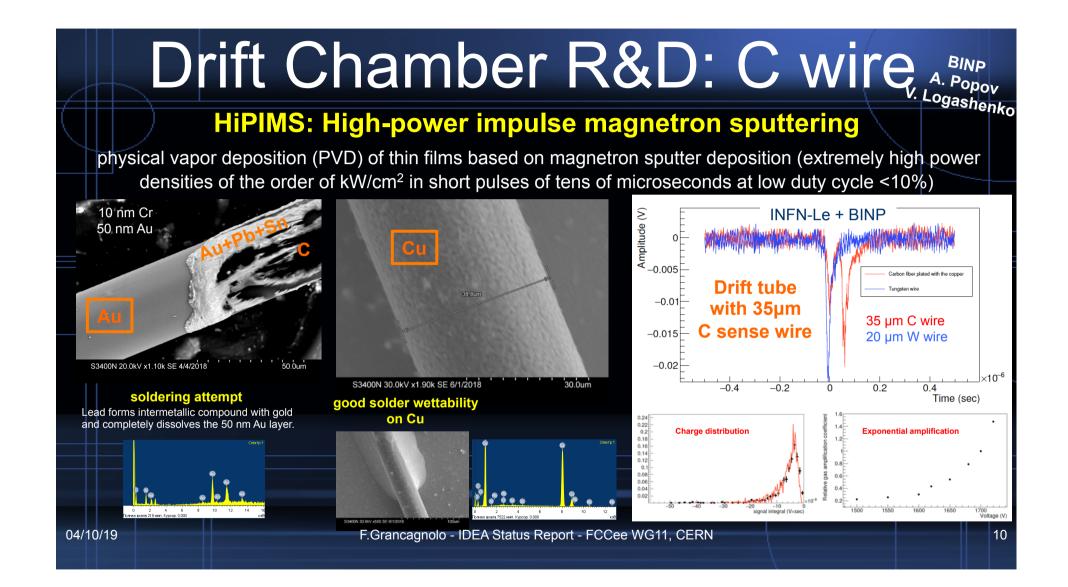
IDEA Drift Chamber: C = 10 pF/m, $V_0 = 1500 \text{ V}$, L = 4.0 m, w = 1.0 cmT > 0.32 N

- 20 μm W sense wire (Y.S. ≈ 1200 MPa): T_{max} = 0.38 N (marginal)
- 40 µm Al field wire (Y.S. ≈ 300 MPa): T_{max} = 0.38 N (marginal)
 - => shorten chamber (loss of acceptance)
 - => widen cell size (increase occupancy)
 - => increase wire diameter (increase multiple scattering and endplate load)

=> replace 40 μm Al with 35 μm Carbon monofilament

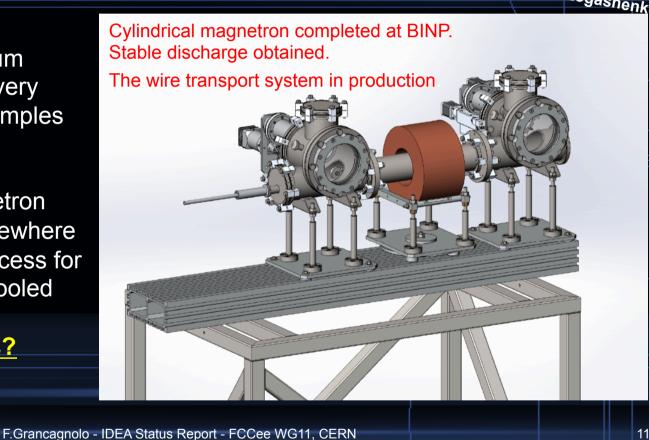
(Y.S. > 860 MPa): T_{max} > 0.83 N

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Drift Chamber R&D: C wire A. Popov V. Logashenko

- Cu coating test of 35 µm carbon monofilament very successful on short samples with HiPIMS at BINP, Novosibirsk
- Investigation of magnetron
 sputtering facilities elsewhere
- Industrialization of process for coating continuous spooled monofilament ongoing
 Different alternatives?



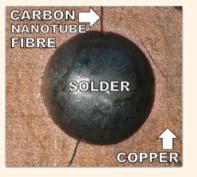
C wire soldering without metal coating

Soldering of Carbon Materials Using **Transition Metal Rich Alloys**

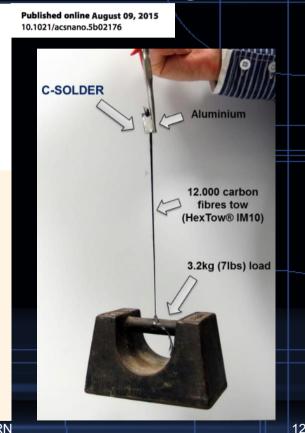
Marek Burda,^{*,†} Agnieszka Lekawa-Raus,[†] Andrzej Gruszczyk,[‡] and Krzysztof K. K. Koziol^{*,†}

[†]Department of Materials Science and Metallurgy, University of Cambridge, 27 Charles Babbage Road, CB3 0FS, Cambridge, U.K. and [‡]Welding Department. Silesian University of Technology, Konarskiego 18a, 44-100 Gliwice, Poland

ABSTRACT Joining of carbon materials via soldering has not been possible up to now due to lack of wetting of carbons by metals at standard soldering temperatures. This issue has been a severely restricting factor for many potential electrical/electronic and mechanical applications of nanostructured and conventional carbon materials. Here we demonstrate the formation of alloys that enable soldering of these structures. By addition of several percent (2.5-5%) of transition metal such a chromium or nickel to a standard lead-free soldering tin based alloy we obtained a solder that can be applied using a commercial soldering iron at typical soldering temperatures of approximator 350 °C and at ambient conditions the use of this solder enables the formation of mechanically strong and electrically conductive joints between carbon materials and, when supported by a simple two-step technique, can successfully bond carbon structures to any metal terminal. It has been shown using optical and scanning electron microscope images as well as X-ray



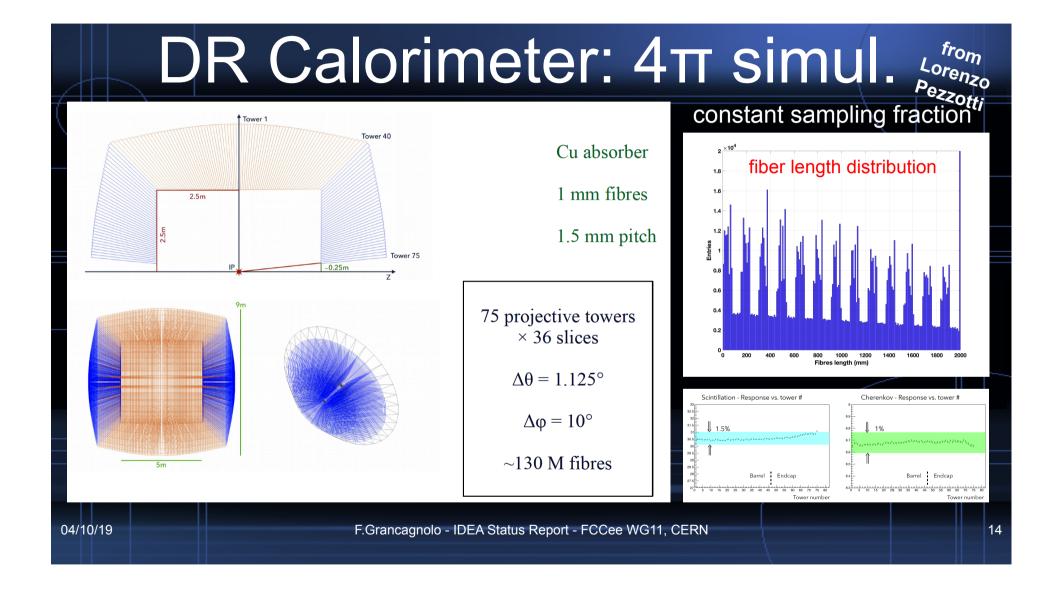
diffraction patterns and energy dispersive X-ray mapping that the successful formation of carbon—solder bonds is possible, first, thanks to the uniform nonreactive dispersion of transition metals in the tin-based matrix. Further, during the soldering process, these free elements diffuse into the carbon-alloy border with no formation of brazing-like carbides, which would damage the surface of the carbon materials.

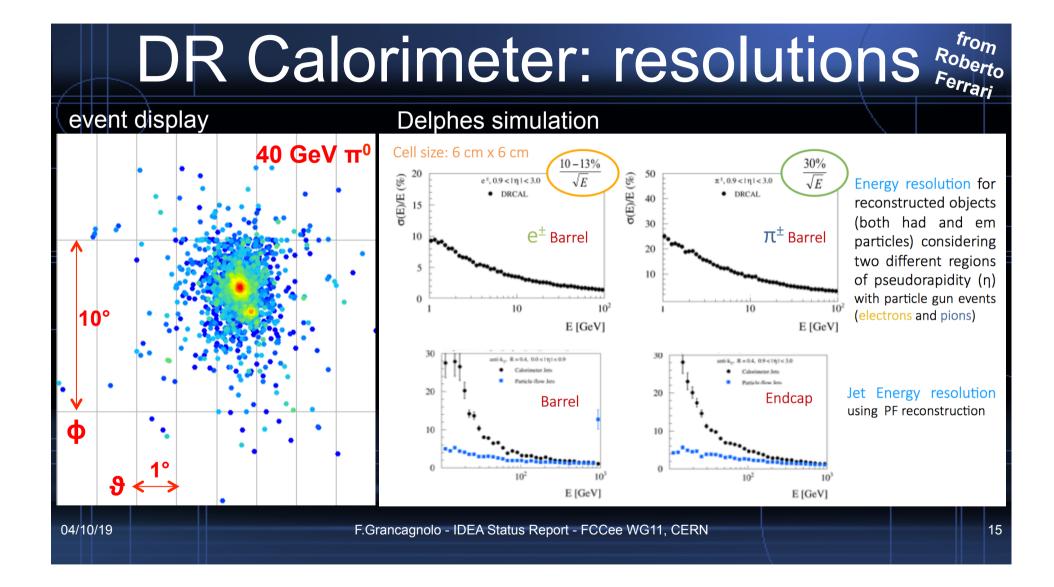


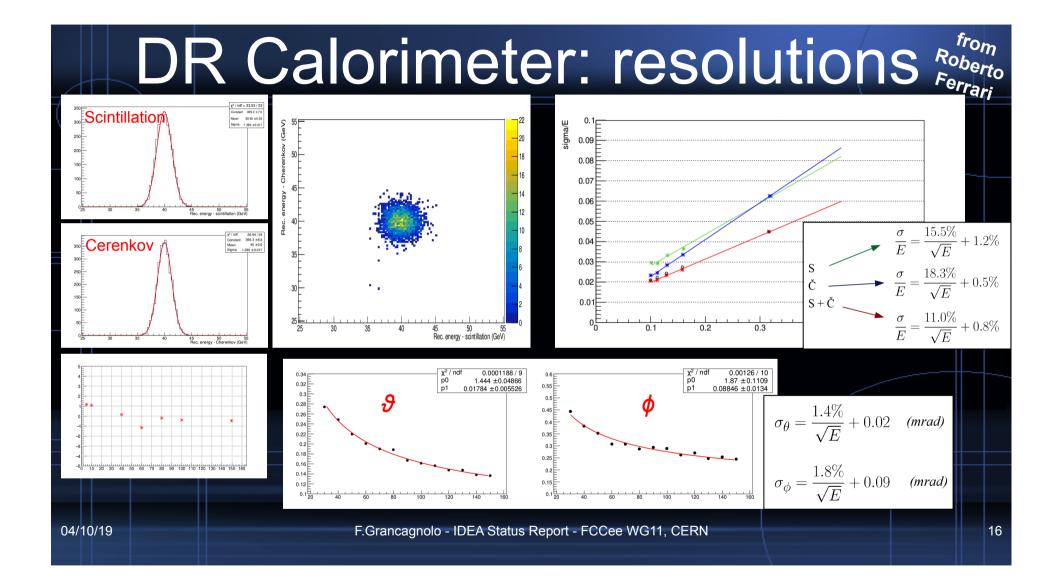
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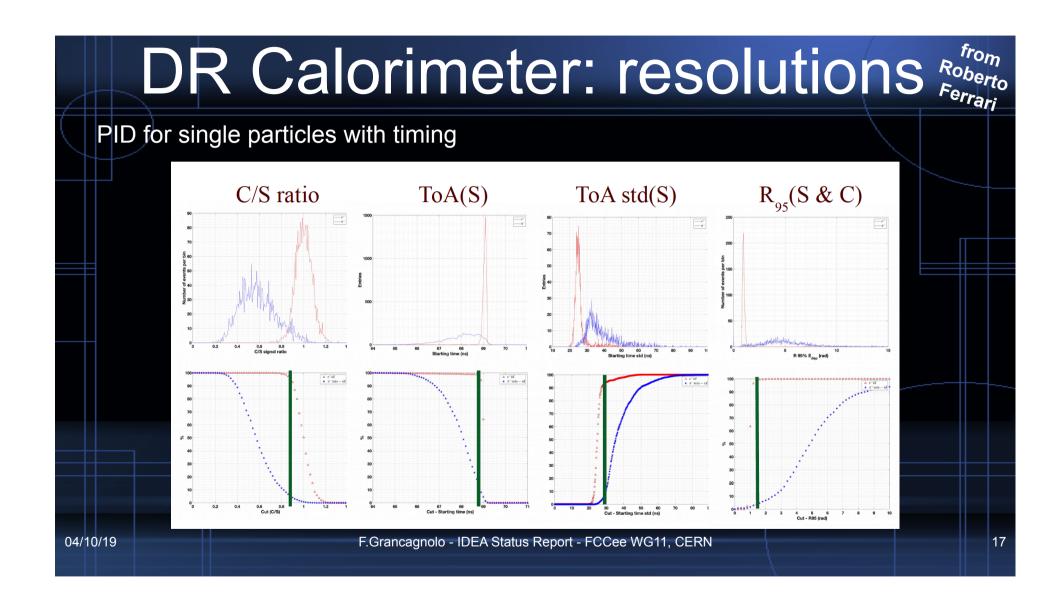
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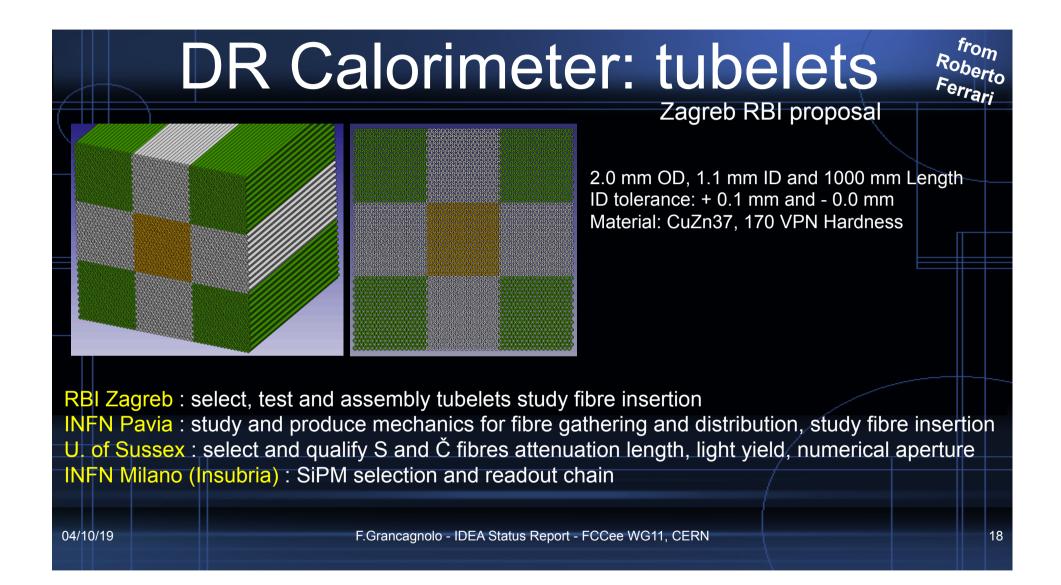


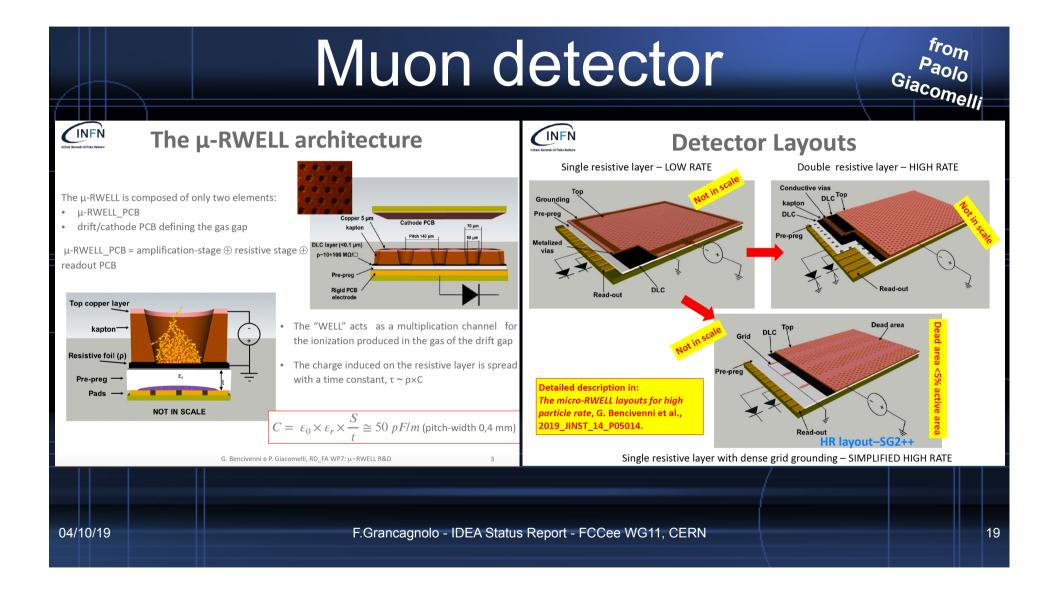


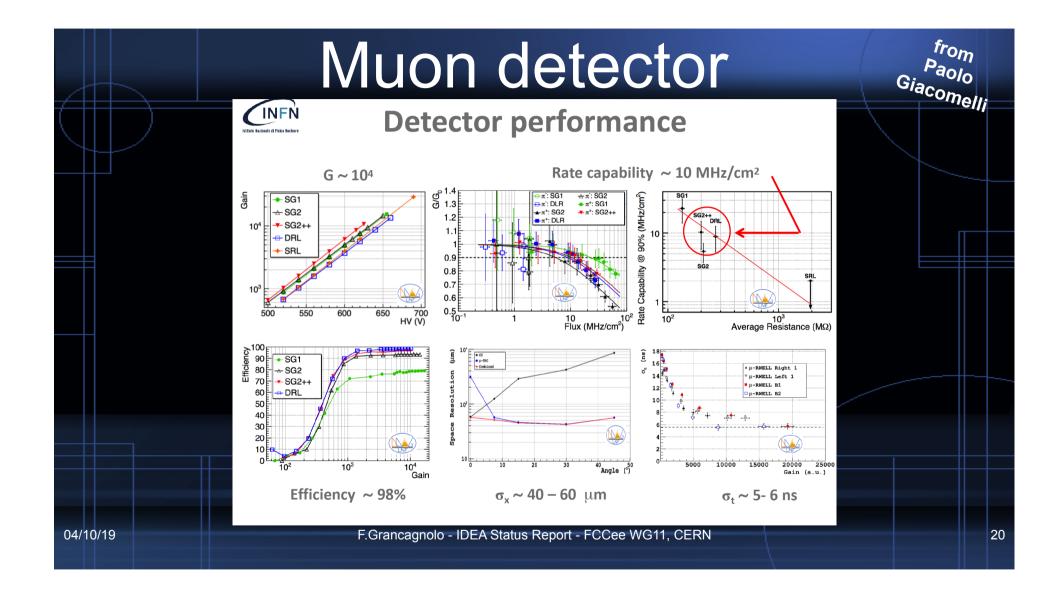


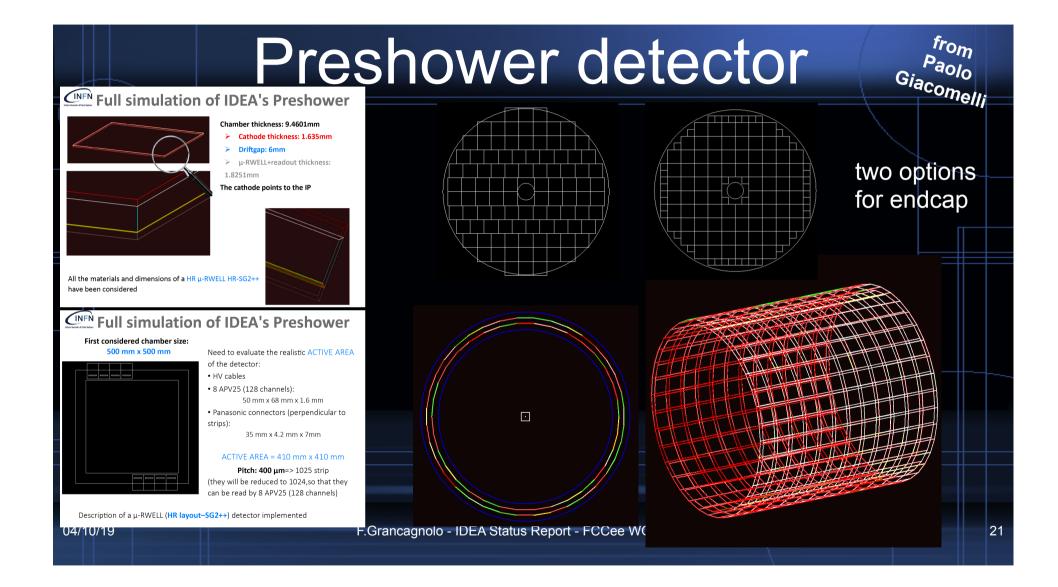












IDEA Eol's

Dual readout calorimeter

- Detector design and construction (Pi, Pv, Mi, Sussex, Korea, USA, Zagreb)
 - Choice of materials (absorber and fibres)
 - Production of the elements
 - Assembly, Quality control
- o Light sensors and Readout (Pv, Mi, Sussex, USA)
 - SiPM, ASIC, FPGA, signal processing and feature extraction

Drift Chamber

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- Cluster Counting/Timing (Le, Ba, BINP)
 - Data reduction and pre-processing of drift chamber signals sampled at high rates
- A prototype of an ultra-light drift chamber (Le, Ba, BINP)
 - With new materials for the next generation of lepton colliders

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IDEA Eol's

- Preshower and Muon detector
 - Innovative ML-based algorithms for tracking in MPGDs (Bo, Fe, LNF)
 Improve particle tracking (for any incident angle) in modern MPGDs (µRWELL, GEM, MicroMegas, etc.)
 - Industrial engineering of high-rate µRWELL detectors with bi-dimensional readout (Bo, Fe, LNF, CERN, Eltos)
 - Development and characterisation of integrated electronics for the readout of pixellated µRWELL detectors (Bo, Fe, To, LNF)

Vertex detector

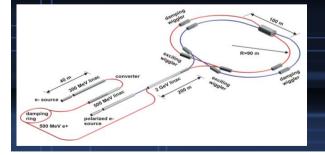
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- Sensor development, ARCADIA-based solution (To, Mi, Tn, Pd, Pv, Bo, Pg)
- Senior development HV-CMOS (Mi, Pv, Pi, Bonn, Strasbourg)
- Optimisation of detector mechanics and cooling (Mi, To, Pd, Tn)

An ultra-low mass Tracking Chamber with Particle Identification capabilities for SCTF at BINP

presented at "Joint Workshop on future tau-charm factory" LAL, Orsay, Dec. 2018

CREMLIN+ Proposal



F. Grancagnolo

INFN – Lecce



Istituto Nazionale di Fisica Nucleare

